

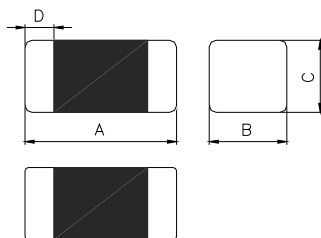
Ferrite Chip Bead(Lead Free) FCM1005MF-Series

1.Features

1. Monolithic inorganic material construction.
2. Closed magnetic circuit avoids crosstalk.
3. S.M.T. type.
4. Suitable for reflow soldering.
5. Shapes and dimensions follow E.I.A. spec.
6. Available in various sizes.
7. Excellent solder ability and heat resistance.
8. High reliability.
9. 100% Lead(Pb) & Halogen-Free and RoHS compliant.



2.Dimensions



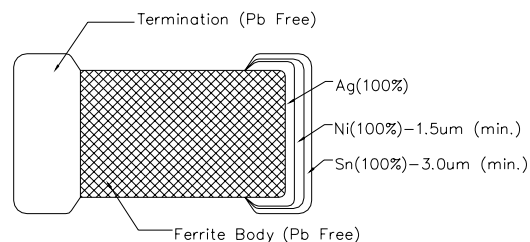
Chip Size	
A	1.00±0.10
B	0.50±0.10
C	0.50±0.10
D	0.25±0.10

Units: mm

3.Part Numbering



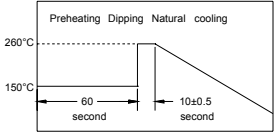
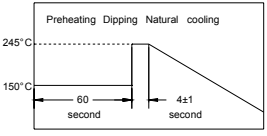
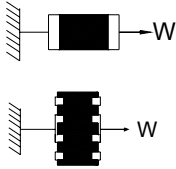
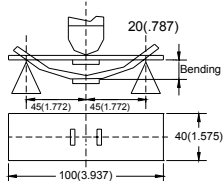
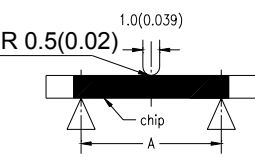
- A: Series
- B: Dimension L x W
- C: Material Lead Free Material
- D: Impedance 600=60
- E: Packaging T=Taping and Reel, B=Bulk(Bags)
- F: Rated Current 01=100mA



4.Specification

Tai-Tech Part Number	Impedance ()	Test Frequency (MHz)	DC Resistance () max.	Rated Current (mA) max.
FCM1005MF-600T01	60±25%	100	0.30	100
FCM1005MF-121T00	120±25%	100	0.45	80
FCM1005MF-221T00	220±25%	100	0.60	50
FCM1005MF-301T00	300±25%	100	0.75	50

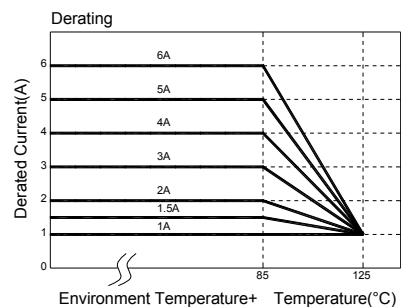
5. Reliability and Test Condition

Item	Performance										Test Condition																								
	FCB	FCM	HCB	GHB	FCA	FCI	FHI	FCH	HCI																										
Series No.											--																								
Operating Temperature	-40~+125 (Including self-temperature rise)					-40~+105 (Including self-temperature rise)					--																								
Transportation Storage Temperature	-40~+125					-40~+105					For long storage conditions, please see the Application Notice																								
Impedance (Z)	Refer to standard electrical characteristics list										Agilent4291																								
Inductance (Ls)											Agilent E4991																								
Q Factor											Agilent4287																								
DC Resistance											Agilent16192																								
Rated Current											Agilent 4338																								
Temperature Rise Test	Rated Current < 1A ΔT 20 Max Rated Current 1A ΔT 40 Max										1. Applied the allowed DC current. 2. Temperature measured by digital surface thermometer.																								
Solder heat Resistance	Appearance: No significant abnormality. Impedance change: Within ± 30%. Inductance change: : within±10%					No mechanical damage. Remaining terminal electrode:75% min.					Preheat: 150 ,60sec. Solder: Sn-Cu0.5 Solder temperature: 260±5 Flux for lead free: ROL0 Dip time: 10±0.5sec. 																								
Solderability	More than 95% of the terminal electrode should be covered with solder.										Preheat: 150 ,60sec. Solder: Sn-Cu0.5 Solder temperature: 245±5 Flux for lead free: ROL0 Dip time: 4±1sec.																								
Terminal strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.										For FCB FCM HCB GHB FCI FHI FCH HCI: Size Force (Kgf) Time(sec) 1005 0.2 1608 0.5 2012 0.6 3216 1.0 >30 3225 1.0 4516 1.0 4532 1.5 For FCA: Size Force (Kgf) Time(sec) 3216 0.5 >30																								
Flexture strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.										Solder a chip on a test substrate, bend the substrate by 2mm (0.079in)and return. The duration of the applied forces shall be 60 (+ 5) Sec.																								
Bending Strength	The ferrite should not be damaged by Forces applied on the right condition.										<table border="1"> <thead> <tr> <th>Size</th> <th>mm(inches)</th> <th>P-Kgf</th> </tr> </thead> <tbody> <tr> <td>1608</td> <td>0.80(0.033)</td> <td>0.3</td> </tr> <tr> <td>2012</td> <td>1.40(0.055)</td> <td>1.0</td> </tr> <tr> <td>FCA3216</td> <td>2.00(0.079)</td> <td>1.5</td> </tr> <tr> <td>3216</td> <td>2.00(0.079)</td> <td>2.5</td> </tr> <tr> <td>3225</td> <td>2.00(0.079)</td> <td>2.5</td> </tr> <tr> <td>4516</td> <td>2.70(0.106)</td> <td>2.5</td> </tr> <tr> <td>4532</td> <td>2.70(0.106)</td> <td>2.5</td> </tr> </tbody> </table>	Size	mm(inches)	P-Kgf	1608	0.80(0.033)	0.3	2012	1.40(0.055)	1.0	FCA3216	2.00(0.079)	1.5	3216	2.00(0.079)	2.5	3225	2.00(0.079)	2.5	4516	2.70(0.106)	2.5	4532	2.70(0.106)	2.5
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Random Vibration Test	Appearance: Cracking, chipping and any other defects harmful to the characteristics should not be allowed. Impedance: within±30% Inductance change: : within±10%.										Frequency: 10-55-10Hz for 15 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 15 min.. This cycle shall be performed 12 times in each of three mutually perpendicular directions (Total 9hours).																								

Item	Performance	Test Condition
Life testing at High Temperature	Appearance: no damage.	Temperature: 125±2 (bead), 85±2 (inductor) Applied current: rated current. Duration: 1000±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Humidity	Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCl)	Humidity: 90~95%RH. Temperature: 40±2 . Temperature: 60±2 .(HCl) Duration: 504±8hrs. Measured at room temperature after placing for 2 to 3hrs.
Thermal shock	Appearance: no damage. Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCl)	Condition for 1 cycle Step1: -40±2 30±5 min. Step2: +105±2 30±5min. Number of cycles: 500 Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test	Q: within±20%of initial value. (HCl)	Temperature: -40±2 . Duration: 500±8hrs. Measured at room temperature after placing for 2 to 3hrs.
Drop	No mechanical damage Impedance change: ±30% Inductance change : within±10%	Drop 10 times on a concrete floor from a height of 75cm

****Derating Curve**

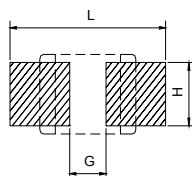
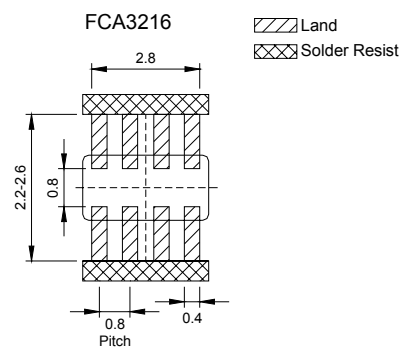
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85 , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



6.Soldering and Mounting

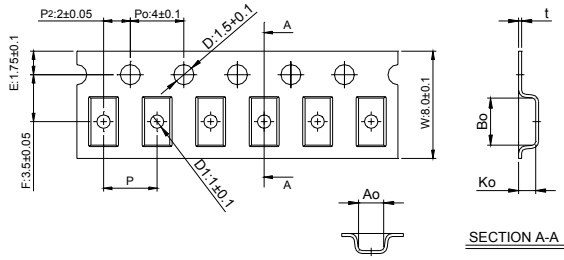
6-1. Recommended PC Board Pattern

Series	Type	Chip Size				Land Patterns For Reflow Soldering		
		A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
FCB	0603	0.6±0.03	0.30±0.03	0.30±0.03	0.15±0.05	0.80	0.30	0.30
	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	1.50	0.40	0.55
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	2.60	0.60	0.80
HCB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	3.00	1.00	1.00
		2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30			
GHB	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	4.40	2.20	1.40
FCI	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	4.40	2.20	3.40
FHI	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	5.70	2.70	1.40
FCH	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	5.90	2.57	4.22
		4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30			



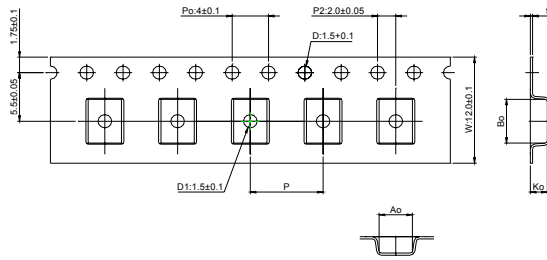
PC board should be designed so that products can prevent damage from mechanical stress when warping the board. Products shall be positioned in the sideway direction against the mechanical stress to prevent failure.

Material of taping is plastic



Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
160808	1.95±0.10	1.05±0.10	1.05±0.10	4.0±0.10	0.23±0.05	none
201209	2.25±0.10	1.42±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10
201212	2.35±0.10	1.50±0.10	1.45±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321611	3.50±0.10	1.88±0.10	1.27±0.10	4.0±0.10	0.22±0.05	1.0±0.10
322513	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321609	3.40±0.10	1.77±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10

7-2.2 Tape Dimension / 12mm

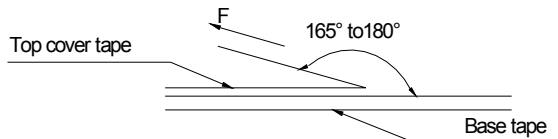


Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
451616	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
453215	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1

7-3. Packaging Quantity

Chip Size	453215	451616	322513	321611	321609	201212	201209	160808	100505	060303
Chip / Reel	1000	2000	2500	3000	3000	2000	4000	4000	10000	15000
Inner box	4000	8000	12500	15000	15000	10000	20000	20000	50000	75000
Middle box	20000	40000	62500	75000	75000	50000	100000	100000	250000	375000
Carton	40000	80000	125000	150000	150000	100000	200000	200000	500000	750000
Bulk (Bags)	12000	20000	30000	50000	50000	100000	150000	200000	300000	--

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp. ()	Room Humidity (%)	Room atm (hPa)	Tearing Speed mm/min
5~35	45~85	860~1060	300

Application Notice

Storage Conditions

To maintain the solder ability of terminal electrodes:

1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
2. Temperature and humidity conditions: Less than 40 and 60% RH.
3. Recommended products should be used within 12 months from the time of delivery.
4. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

Impedance Frequency Characteristics(Typical)

